

# N-CHANNEL GaAs HJ-FET NE651R479A

# 0.4 W L-BAND POWER GaAs HJ-FET

#### **DESCRIPTION**

The NE651R479A is a 0.4 W GaAs HJ-FET designed for middle power transmitter applications for mobile communication and wireless PC LAN systems. It is capable of delivering 0.4 W of output power (CW) with high linear gain, high efficiency and excellent distortion and as a driver amplifier for our NE6510179A and NE6510379A.

Reliability and performance uniformity are assured by NEC's stringent quality and control procedures.

#### **★ FEATURES**

· GaAs HJ-FET structure

• High output power :  $P_{\text{out}} = +27.0 \text{ dBm TYP}$ . @  $V_{DS} = 3.5 \text{ V}$ ,  $I_{Dset} = 50 \text{ mA}$ , f = 900 MHz,  $P_{\text{in}} = +13 \text{ dBm}$ 

 $P_{\text{out}} = +27.0 \text{ dBm TYP.} \ @ \ \text{V}_{\text{DS}} = 3.5 \text{ V}, \ I_{\text{Dset}} = 50 \text{ mA}, \ f = 1.9 \text{ GHz}, \ P_{\text{in}} = +15 \text{ dBm}$ 

Pout = +29.5 dBm TYP. @ VDS = 5.0 V, IDset = 50 mA, f = 1.9 GHz, Pin = +15 dBm

• High linear gain :  $G_L = 14.0 \text{ dB TYP}$ . @  $V_{DS} = 3.5 \text{ V}$ ,  $I_{Dset} = 50 \text{ mA}$ , f = 900 MHz,  $P_{in} = 0 \text{ dBm}$ 

GL=12.0~dB TYP. @ VDS = 3.5 V, IDset = 50 mA, f = 1.9 GHz, Pin = 0 dBm

 $G_L = 12.0 \text{ dB TYP.} @ V_{DS} = 5.0 \text{ V}, I_{Dset} = 50 \text{ mA}, f = 1.9 \text{ GHz}, P_{in} = 0 \text{ dBm}$ 

High power added efficiency: 60 % TYP. @ VDS = 3.5 V, IDset = 50 mA, f = 900 MHz, Pin = +13 dBm

60 % TYP. @  $V_{DS} = 3.5 \text{ V}$ ,  $I_{Dset} = 50 \text{ mA}$ , f = 1.9 GHz,  $P_{in} = +15 \text{ dBm}$ 

58 % TYP. @  $V_{DS} = 5.0 \text{ V}$ ,  $I_{Dset} = 50 \text{ mA}$ , f = 1.9 GHz,  $P_{in} = +15 \text{ dBm}$ 

### **ORDERING INFORMATION**

Part Number	Package	Supplying Form
NE651R479A-T1	79A	12 mm wide embossed taping     Qty 1 kpcs/reel

**Remark** To order evaluation samples, consult your NEC sales representative (Part number for sample order: NE651R479A).

Caution Please handle this device at static-free workstation, because this is an electrostatic sensitive device.

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.

Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

# ABSOLUTE MAXIMUM RATINGS (TA = +25 °C)

Operation in excess of any one of these parameters may result in permanent damage.

Parameter	Symbol	Ratings	Unit
Drain to Source Voltage	V <sub>DS</sub>	8	V
Gate to Source Voltage	Vgso	-4	V
Drain Current	lσ	1.0	Α
Gate Forward Current	lgf	10	mA
Gate Reverse Current	Igr	10	mA
Total Power Dissipation	P <sub>tot</sub>	2.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-65 to +150	°C

# RECOMMENDED OPERATING CONDITIONS

	Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
*	Drain to Source Voltage	VDS		_	3.5	5.5	V
	Gain Compression	Gcomp		1	Į.	5.0 Note	dB
	Channel Temperature	Tch		_	-	+110	°C

**Note** Recommended maximum Gain Compression is 3.0 dB at V<sub>DS</sub> > 4.2 V

## **ELECTRICAL CHARACTERISTICS**

(T<sub>A</sub> = +25 °C, unless otherwise specified, using NEC standard test fixture.)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Saturated Drain Current	Ioss	V <sub>DS</sub> = 2.5 V, V <sub>GS</sub> = 0 V	1	0.7	-	Α
Pinch-off Voltage	$V_p$	V <sub>DS</sub> = 2.5 V, I <sub>D</sub> = 14 mA	-2.0	1	-0.4	V
Gate to Drain Break Down Voltage	$BV_gd$	I <sub>gd</sub> = 14 mA	12	1	ı	V
Thermal Resistance	Rth	Channel to Case	1	30	50	°C/W
Output Power	Pout	f = 1.9 GHz, V <sub>DS</sub> = 3.5 V,	26.0	27.0	_	dBm
Drain Current	lσ	$P_{in}$ = +15 dBm, $R_g$ = 1 k $\Omega$ ,	1	220	-	mA
Power Added Efficiency	$\eta$ add	I <sub>Dset</sub> = 50 mA (RF OFF)	52	60	-	%
Linear Gain Note 1	GL	Note 2	-	12.0	-	dB

Notes 1. Pin = 0 dBm

**2.** DC performance is 100 % testing. RF performance is testing several samples per wafer. Wafer rejection criteria for standard devices is 1 reject for several samples.



#### TYPICAL RF PERFORMANCE FOR REFERENCE (NOT SPECIFIED)

(TA = +25 °C, unless otherwise specified, using NEC standard test fixture.)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Output Power	Pout	f = 900 MHz, V <sub>DS</sub> = 3.5 V,	-	27.0	-	dBm
Drain Current	ΙD	$P_{in}$ = +13 dBm, $R_g$ = 1 k $\Omega$ ,	-	230	-	mA
Power Added Efficiency	$\eta$ add	IDset = 50 mA (RF OFF)	_	60	-	%
Linear Gain Note	GL		-	14.0	-	dB

Note Pin = 0 dBm

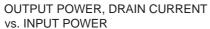
# **★** TYPICAL RF PERFORMANCE FOR REFERENCE (NOT SPECIFIED)

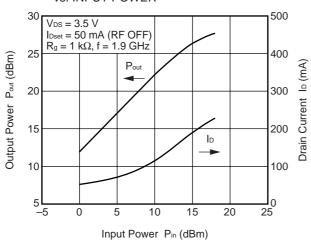
(TA = +25 °C, unless otherwise specified, using NEC standard test fixture.)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Output Power	Pout	f = 1.9 GHz, Vps = 5.0 V,	_	29.5	1	dBm
Drain Current	ΙD	$P_{in}$ = +15 dBm, $R_g$ = 1 k $\Omega$ ,	_	350	1	mA
Power Added Efficiency	$\eta$ add	I <sub>Dset</sub> = 50 mA (RF OFF)	-	58	-	%
Linear Gain Note	G∟		ı	12.0	1	dB

Note Pin = 0 dBm

# **★ TYPICAL CHARACTERISTICS (TA = +25 °C)**





**Remark** The graph indicates nominal characteristics.

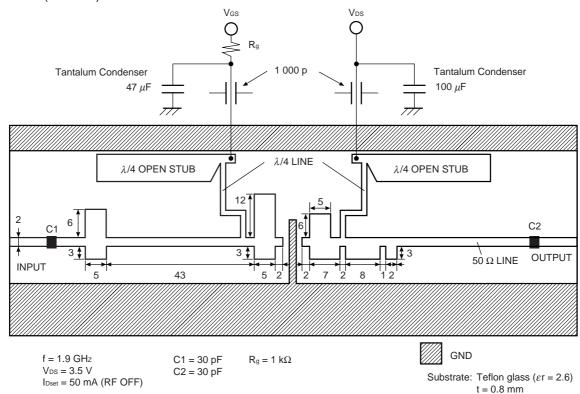
# **S-PARAMETERS**

Test Conditions: VDS = 3.5 V, IDset = 50 mA (RF OFF)

Frequency		S <sub>11</sub>		S <sub>21</sub>		<b>S</b> <sub>12</sub>		S <sub>22</sub>
GHz	MAG.	ANG. (deg.)	MAG.	ANG. (deg.)	MAG.	ANG. (deg.)	MAG.	ANG. (deg.)
600	0.868	-168.8	6.120	96.9	0.046	15.7	0.536	-170.3
700	0.866	-172.7	5.225	95.0	0.046	14.9	0.537	-173.9
800	0.864	-176.9	4.641	93.0	0.045	14.8	0.541	-177.1
900	0.863	-179.4	4.145	91.6	0.045	15.4	0.540	-179.6
1000	0.868	176.6	3.730	89.4	0.045	15.8	0.541	178.0
1100	0.862	173.6	3.359	88.3	0.045	16.6	0.542	175.5
1200	0.860	170.8	3.152	87.5	0.046	16.6	0.542	173.4
1300	0.861	168.3	2.894	85.8	0.047	15.7	0.535	171.9
1400	0.859	165.4	2.695	85.2	0.047	15.5	0.533	170.1
1500	0.861	162.2	2.527	84.2	0.046	16.1	0.533	167.8
1600	0.862	159.3	2.387	82.9	0.046	17.0	0.533	165.9
1700	0.857	156.7	2.261	82.8	0.047	17.1	0.532	163.8
1800	0.855	153.5	2.229	80.9	0.046	17.0	0.537	161.1
1900	0.856	150.0	2.093	77.8	0.046	16.6	0.538	158.4
2000	0.860	146.7	1.946	76.9	0.045	16.3	0.537	156.0
2100	0.860	142.9	1.884	75.5	0.045	16.9	0.533	154.0
2200	0.863	140.1	1.785	73.6	0.045	18.4	0.533	149.6

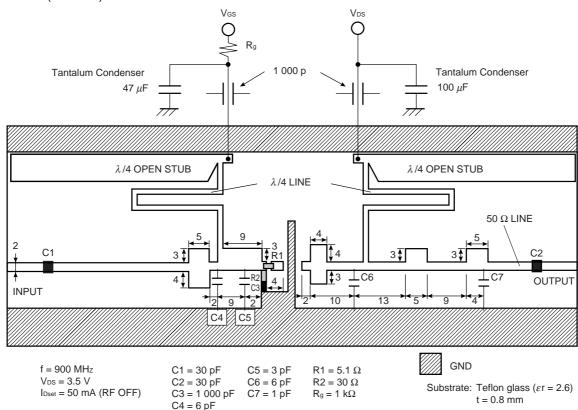
# **APPLICATION CIRCUIT EXAMPLE**

f = 1.9 GHz (Unit: mm)

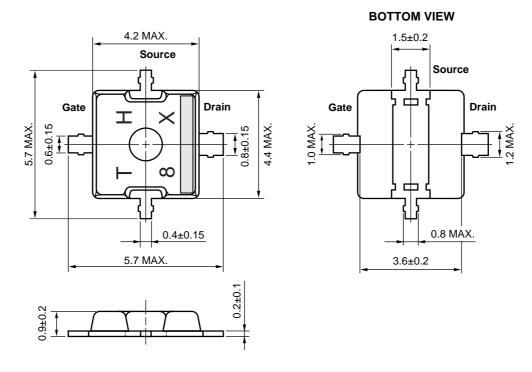


# **APPLICATION CIRCUIT EXAMPLE**

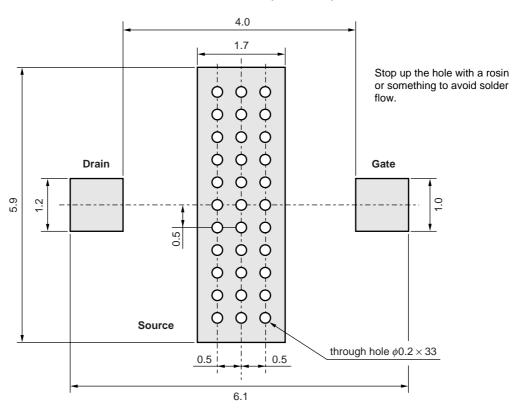
f = 900 MHz (Unit: mm)



# 79A PACKAGE DIMENSIONS (Unit: mm)



# 79A PACKAGE RECOMMENDED P.C.B. LAYOUT (Unit: mm)



6



#### RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your NEC sales representative.

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared Reflow	Package peak temperature: 235 °C or below, Time: 30 seconds or less (at 210 °C or higher), Count: 2 times or less, Exposure: limit: None Note	IR35-00-2
Partial Heating	Pin temperature: 260 °C or below, Time: 5 seconds or less (per pin row) Exposure: limit: None Note	-

**Note** After opening the dry pack, store it at 25 °C or less and 65 % RH or less for the allowable storage period.

Caution Do not use different soldering methods together (except for partial heating).

7

## **CAUTION**

The great care must be taken in dealing with the devices in this guide.

The reason is that the material of the devices is GaAs (Gallium Arsenide), which is designated as harmful substance according to the law concerned.

Keep the law concerned and so on, especially in case of removal.

- The information in this document is current as of June, 2000. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC's data sheets or data books, etc., for the most up-to-date specifications of NEC semiconductor products. Not all products and/or types are available in every country. Please check with an NEC sales representative for availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without prior written consent of NEC. NEC assumes no responsibility for any errors that may appear in this document.
- NEC does not assume any liability for infringement of patents, copyrights or other intellectual property rights of
  third parties by or arising from the use of NEC semiconductor products listed in this document or any other
  liability arising from the use of such products. No license, express, implied or otherwise, is granted under any
  patents, copyrights or other intellectual property rights of NEC or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of customer's equipment shall be done under the full responsibility of customer. NEC assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC endeavours to enhance the quality, reliability and safety of NEC semiconductor products, customers
  agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize
  risks of damage to property or injury (including death) to persons arising from defects in NEC
  semiconductor products, customers must incorporate sufficient safety measures in their design, such as
  redundancy, fire-containment, and anti-failure features.
- NEC semiconductor products are classified into the following three quality grades:
  - "Standard", "Special" and "Specific". The "Specific" quality grade applies only to semiconductor products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of a semiconductor product depend on its quality grade, as indicated below. Customers must check the quality grade of each semiconductor product before using it in a particular application.
  - "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
  - "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
  - "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC semiconductor products is "Standard" unless otherwise expressly specified in NEC's data sheets or data books, etc. If customers wish to use NEC semiconductor products in applications not intended by NEC, they must contact an NEC sales representative in advance to determine NEC's willingness to support a given application.

(Note)

- (1) "NEC" as used in this statement means NEC Corporation and also includes its majority-owned subsidiaries.
- (2) "NEC semiconductor products" means any semiconductor product developed or manufactured by or for NEC (as defined above).

M8E 00.4